

Notice of References Cited	Application/Control No. 10/731,757	Applicant(s)/Patent Under Reexamination YANG ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0198877	10-2004	Yang et al.	524/115
	B	US-2004/0192814	09-2004	Yang et al.	524/115
	C	US-5,905,122	05-1999	Ohtsuka et al.	525/465
	D	US-5,731,390	03-1998	Helmond, Johannes van	525/438
	E	US-4,062,909	12-1977	Morgan et al.	558/157
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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